Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	0	robert same faiser.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:31
L2	0	robert same falser.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:31
L3	85	robert same falster.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:41
L4	1	I3 and average adj void adj density	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:42
L5	0	vladimir same varonkov.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:42
L6	14	vladimir same voronkov.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:43
L7	1	l6 not 13	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:43
L8	22	paolo same mutti.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:43
l 19	2	18 not 13	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:44
L10	0	francesco same bonoli.in.	US-PGPUB; USPAT	OR	OFF	2004/12/10 14:44
S1	2	average adj void adj density	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:14
S2	65	density same agglomerated adj defects	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:48
S3	66	(void adj density) not (density same agglomerated adj defects)	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:19
S4	68	density same agglomerated adj defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2004/03/04 17:23
<b>S5</b>	38	density near agglomerated adj defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/03/04 17:23
<b>S6</b>		(density near agglomerated adj defects) not (density same agglomerated adj defects)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/03/04 17:23
<b>S7</b>	1929			OR C	OFF 2	2004/03/04 17:25

S8		l "l18" near defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	,	OFF	2004/03/04 17:24
S9	217	(density same agglomerated) and defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB		OFF	2004/03/04 17:26
S10	68	density same agglomerated near defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/03/04 17:25
<b>\$11</b>	0	(density same agglomerated near defects) not (density same agglomerated adj defects)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/03/04 17:25
S12	80	agglomerated adj defects	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2004/03/04 17:26
S13	77	(agglomerated adj defects) and density	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2004/03/04 17:26
S14	9	((agglomerated adj defects) and density) not (density same agglomerated adj defects)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF .	2004/03/04 17:27
515	67	void adj density	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:42
516	0	high adj denstiy same agglomerated adj defects	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:49
317	<b>O</b>	high adj denstiy same vacancy adj defects	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:49
518	0	high adj denstiy same vacancy	US-PGPUB; USPAT	OR	OFF	2004/03/04 17:49
19	628	void adj size	US-PGPUB; USPAT	OR	OFF	2004/03/05 10:59
20	1	void adj size near radius	US-PGPUB; USPAT	OR	OFF :	2004/03/05 10:59
21	31	void adj radius	US-PGPUB; USPAT	OR	OFF :	2004/03/05 11:00

S22	1	(void adj size) and agglomerated adj defects	US-PGPUB; USPAT	OR	OFF	2004/03/05 11:00
S23	7	(void adj size) and defects and vacancy	US-PGPUB; USPAT	OR	OFF	2004/03/05 11:12
S24	994	defect adj size	US-PGPUB; USPAT	OR	OFF	2004/03/05 11:23
S25	1218	small adj voids	US-PGPUB;	OR	OFF	2004/03/05 13:11
S26	40	(small adj voids) and silicon adj wafer	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:15
S27	5	((small adj voids) and silicon adj wafer) and void near size	US-PGPUB; USPAT	OR	OFF	2004/03/05 13:15
S28	879	428/64.1.ccls.	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:15
S29	0	428/64.1.ccls. and void adj density	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:15
S30	118	428/64.1.ccls. and defects	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:15
S31	890	428/64.4.ccls.	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:16
S32	7	428/64.4.ccls. and silicon adj wafers	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:16
S33 -	428	117/13.ccls.	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:16
S34	190	117/13.ccls. and ingot	US-PGPUB; USPAT	OR	OFF .	2004/03/05 15:16
S35	133	(117/13.ccls. and ingot) and defects	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:18
S36	122	117/20.ccls.	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:18
S37	554	117/932.ccis,	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:18
S38	26	117/932.ccls. and voids	US-PGPUB; USPAT	OR	OFF	2004/03/05 15:18